

# UNISONIC TECHNOLOGIES CO., LTD

7NM80 Preliminary Power MOSFET

## 7.0A, 800V N-CHANNEL SUPER-JUNCTION MOSFET

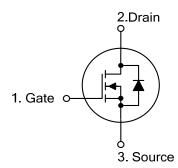
#### DESCRIPTION

The **UTC 7NM80** is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

#### ■ FEATURES

- \*  $R_{DS(ON)}$  < 0.94 $\Omega$  @  $V_{GS}$  = 10V,  $I_D$  = 3.5A
- \* Fast switching capability
- \* Avalanche energy tested
- \* Improved dv/dt capability, high ruggedness

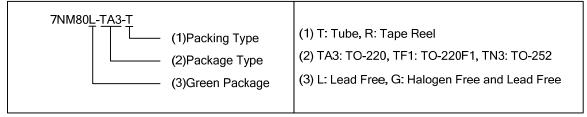




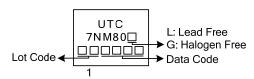
### ■ ORDERING INFORMATION

Ordering Number		Daakaga	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
7NM80L-TA3-T	7NM80G-TA3-T	TO-220	G	D	S	Tube	
7NM80L-TF1-T	7NM80G-TF1-T	TO-220F1	G	D	S	Tube	
7NM80L-TN3-T	7NM80G-TN3-T	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



### ■ MARKING



TO-220 TO-220F1 TO-252

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## ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> =25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{DSS}$	800	V	
Gate-Source Voltage		$V_{GSS}$	±30	V	
Drain Current	Continuous	I <sub>D</sub>	7.0	Α	
	Pulsed (Note 2)	I <sub>DM</sub>	28	Α	
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	420	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	6.2	V/ns	
Power Dissipation	TO-220		142	W	
	TO-220F1	$P_{D}$	52	W	
	TO-252		83	W	
Junction Temperature		$T_J$	+150	°C	
Storage Temperature Range		$T_{STG}$	-55 ~ <b>+</b> 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=159mH,  $I_{AS}$ =2.3A,  $V_{DD}$ =50V,  $R_{G}$ =25 $\Omega$ , Starting  $T_{J}$  = 25 $^{\circ}$ C.
- 4.  $I_{SD} \le 7.0 A$ ,  $di/dt \le 200 A/\mu s$ ,  $V_{DD} \le V_{(BR)DSS}$ ,  $T_J = 25 ^{\circ} C$ .

#### **■ THERMAL DATA**

PARAMETER		SYMBOL	RATING	UNIT
Junction to Ambient	TO-220	0	62.5	°C/W
	TO-252	$\theta_{JA}$	110	°C/W
Junction to Case	TO-220		0.88	°C/W
	TO-220F1	$\theta_{JC}$	2.4	°C/W
	TO-252		1.5	°C/W

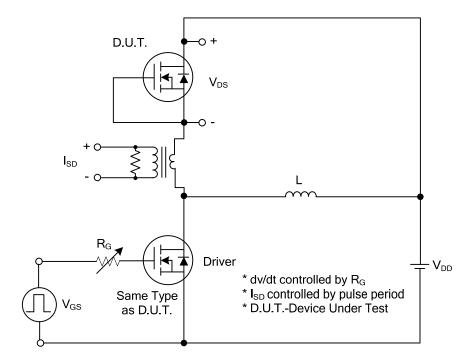
## ■ **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub>=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	800			V		
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =800V, V <sub>GS</sub> =0V			10	μA		
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V ,V <sub>GS</sub> =±30V			±100	nA		
ON CHARACTERISTICS								
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$			4.5	V		
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 3.5A			0.94	Ω		
DYNAMIC PARAMETERS								
Input Capacitance	$C_{ISS}$			620		pF		
Output Capacitance	Coss	$V_{GS}$ =0V, $V_{DS}$ =25V, f=1.0MHz		244		pF		
Reverse Transfer Capacitance	$C_{RSS}$	]		18		pF		
SWITCHING PARAMETERS								
Total Gate Charge (Note 1)	$Q_{\mathrm{G}}$	V <sub>DS</sub> =50V, V <sub>GS</sub> =10V, I <sub>D</sub> =1.3A , -I <sub>G</sub> =100μA (Note 1, 2)		46		nC		
Gate to Source Charge	$Q_GS$			5		nC		
Gate to Drain Charge	$Q_GD$			16		nC		
Turn-ON Delay Time (Note 1)	$t_{D(ON)}$			56		ns		
Rise Time	$t_R$	$V_{DD}$ =30V, $V_{GS}$ =10V, $I_{D}$ =0.5A,		120		ns		
Turn-OFF Delay Time	t <sub>D(OFF)</sub>	R <sub>G</sub> =25Ω (Note 1, 2)		272		ns		
Fall-Time	$t_{F}$			68		ns		
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current	Is				7.0	Α		
Maximum Body-Diode Pulsed Current	I <sub>SM</sub>				28	Α		
Drain-Source Diode Forward Voltage (Note 1)	$V_{SD}$	I <sub>S</sub> =3.5A, V <sub>GS</sub> =0V			1.4	V		
Body Diode Reverse Recovery Time (Note 1)	t <sub>rr</sub>	I <sub>S</sub> =7.0A, V <sub>GS</sub> =0V,		450		ns		
Body Diode Reverse Recovery Charge	$Q_{rr}$	dI <sub>F</sub> /dt=100A/μs		6		μC		

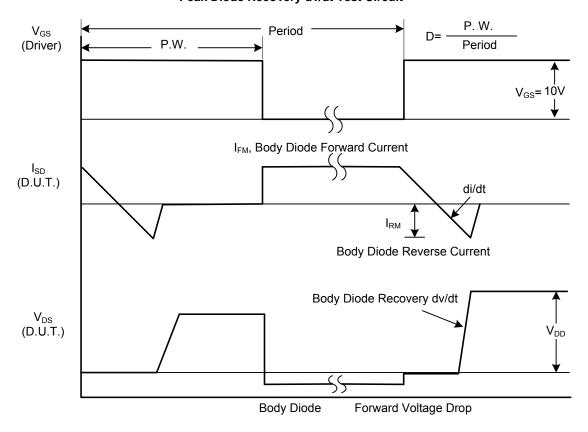
Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%.

<sup>2.</sup> Essentially independent of operating temperature.

## TEST CIRCUITS AND WAVEFORMS

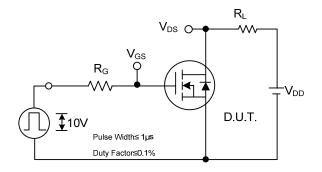


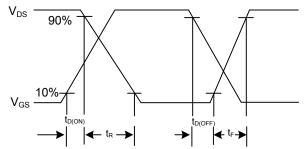
## Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

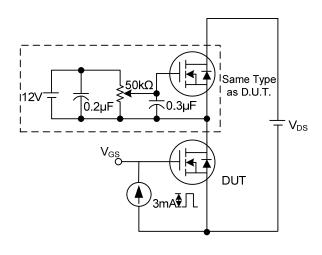
## ■ TEST CIRCUITS AND WAVEFORMS (Cont.)

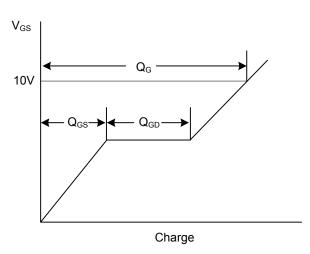




**Switching Test Circuit** 

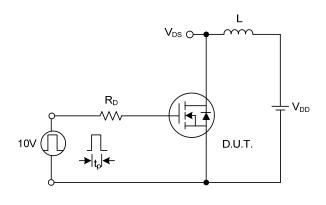
**Switching Waveforms** 

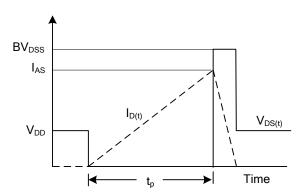




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 





**Unclamped Inductive Switching Test Circuit** 

**Unclamped Inductive Switching Waveforms** 

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